


<b>Search Notes</b>  	<b>Application/Control No.</b>  10539804	<b>Applicant(s)/Patent Under Reexamination</b>  INOUE ET AL.
	<b>Examiner</b>  Patidar, Jay M	<b>Art Unit</b>  2862

SEARCHED			
Class	Subclass	Date	Examiner
324	207.18	5/21	JP

SEARCH NOTES		
Search Notes	Date	Examiner
Search updated. EAST searched.	5/21	JP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
324	207.25,173	5/21	JP